

**General Description**

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ .

**Features**

- AEC-Q101 Qualified
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

**Application**

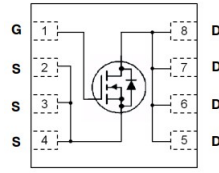
- BLDC Motor driver
- DC-DC
- Load Switch

**Ordering Information:**

Part NO.	ZMSA004N04HG
Marking	ZMS004N04H
Packing Information	REEL TAPE
Basic ordering unit (pcs)	2500

**Absolute Maximum Ratings** ( $T_C=25^\circ\text{C}$ )

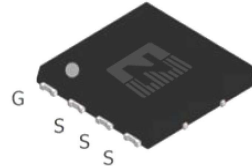
Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	$V_{DS}$		40	V
Gate-Source Voltage <sup>①</sup>	$V_{GS}$		$\pm 20$	V
Continuous Drain Current	$I_D$	$T_C=25^\circ\text{C}$	475	A
	$I_D$	$T_C=75^\circ\text{C}$	452	A
	$I_D$	$T_C=100^\circ\text{C}$	391	A
Pulsed Drain Current	$I_{DM}$	Pulsed; $t_p \leq 10 \mu\text{s}$ ; $T_{mb} = 25^\circ\text{C}$ ;	1425	A
Total Power Dissipation	$P_D$	$T_C=25^\circ\text{C}$	250	W
Total Power Dissipation	$P_D$	$T_A=25^\circ\text{C}$	4.3	W
Operating Junction Temperature	$T_J$		-55 to +175	$^\circ\text{C}$
Storage Temperature	$T_{STG}$		-55 to +175	$^\circ\text{C}$
Single Pulse Avalanche Energy	$E_{AS}$	$L=0.1\text{mH}$ , $V_{GS}=10\text{V}$ , $R_g=25\Omega$ ,	560	mJ
		$L=0.5\text{mH}$ , $V_{GS}=10\text{V}$ , $R_g=25\Omega$ ,	1176	mJ
ESD Level (HBM)	CLASS 2			

**Product Summary**

$$V_{DS} = 40\text{V}$$

$$R_{DS(ON)} = 0.4\text{m}\Omega$$

$$I_D = 475\text{A}$$



DFN8\*8





## •Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	$R_{thJC}$		-	0.6	°C/W
Thermal resistance, junction-ambient	$R_{thJA}^{②}$		-	35	°C/W
Soldering temperature	$T_{sold}$		-	260	°C

## •Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	40			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	2.0	2.7	4.0	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{GS}=0V, V_{DS}=40V$			1.0	$\mu A$
Gate- Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$			100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=40A$		0.4	0.48	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{GS}=5V, I_{SD}=20A$		60		s
Diode Forward Voltage	$V_{FSD}$	$V_{GS}=0V, I_{SD}=40A$			1.3	V

 $V_{DS}=5V, I_{SD} =$ 

## •Dynamic characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	$C_{iss}$	$f = 1MHz, V_{DS}=25V$	-	10860	-	pF
Output capacitance	$C_{oss}$		-	3040	-	
Reverse transfer capacitance	$C_{rss}$		-	168	-	
Gate Resistance	$R_g$	$f = 1MHz$	-	3.2		$\Omega$
Total gate charge	$Q_g$	$V_{DD}=15V, I_D=20A, V_{GS}=10V$	-	174	-	nC
Gate - Source charge	$Q_{gs}$		-	42	-	
Gate - Drain charge	$Q_{gd}$		-	38	-	
Turn-ON Delay time	$t_{D(on)}$	$V_{GS}=10V, V_{DS}=15V, R_G=3.3\Omega, I_D=20A$	-	75	-	ns
Turn-ON Rise time	$t_r$		-	78	-	ns
Turn-Off Delay time	$t_{D(off)}$		-	120	-	ns
Turn-Off Fall time	$t_f$		-	55	-	ns
Reverse Recovery Time	$t_{RR}$		$V_{DD}=20V, di_s/dt = 100A/\mu s, I_S=50A$	-	96	-
Reverse Recovery Charge	$Q_{RR}$	-		230	-	nC



Fig.1 Gate-Charge Characteristics

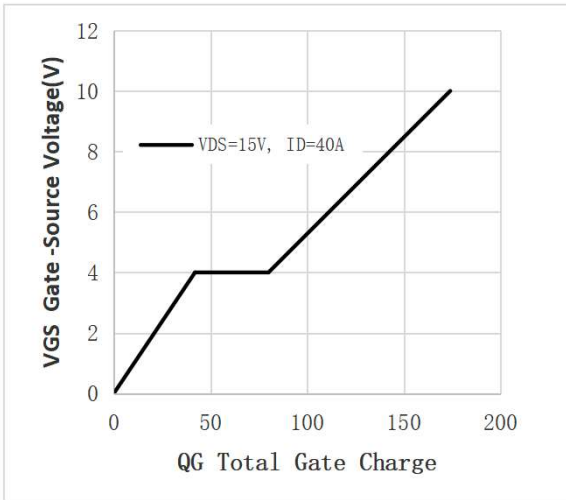


Fig.2 Capacitance Characteristics

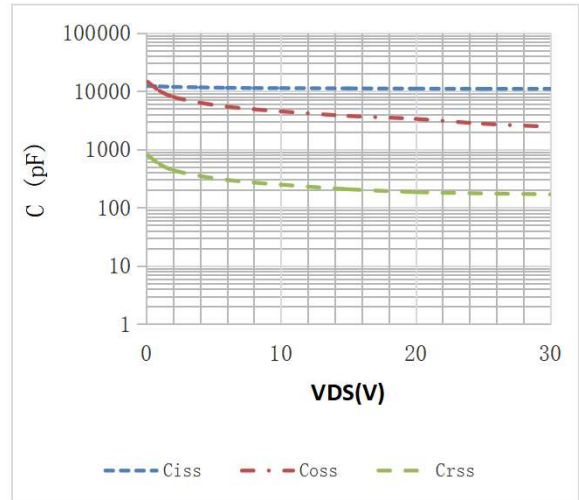


Fig.3 Power Dissipation

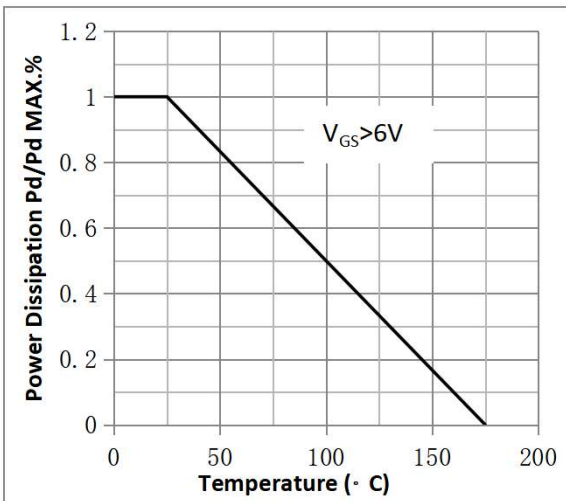


Fig.4 Typical output Characteristics

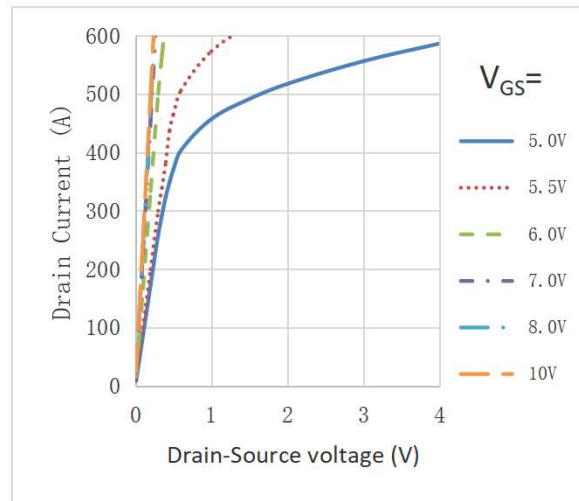


Fig.5 Threshold Voltage V.S Junction Temperature

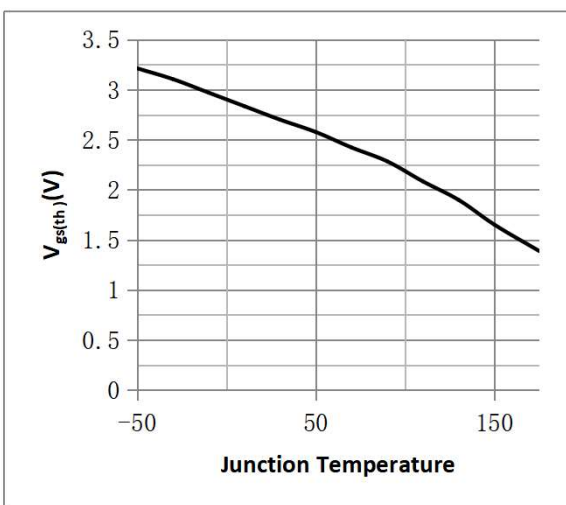


Fig.6 Resistance V.S Drain Current

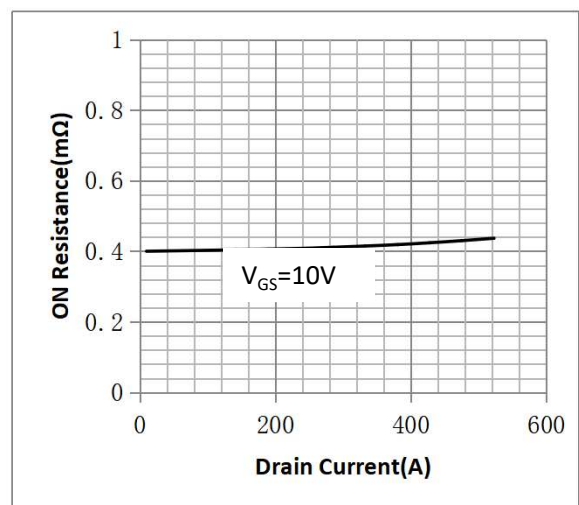




Fig.7 On-Resistance VS Gate Source Voltage

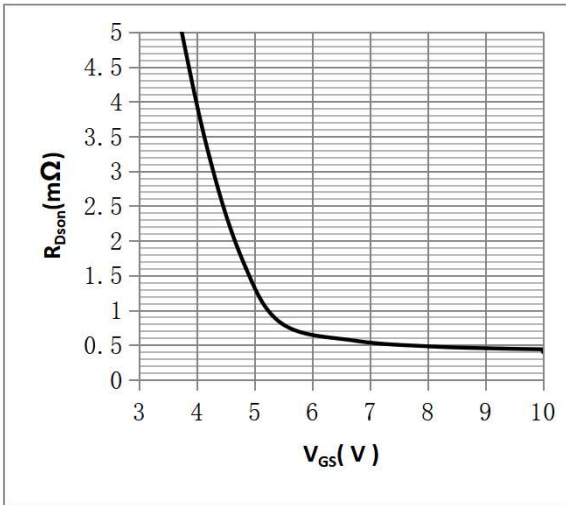


Fig.8 On-Resistance V.S Junction Temperature

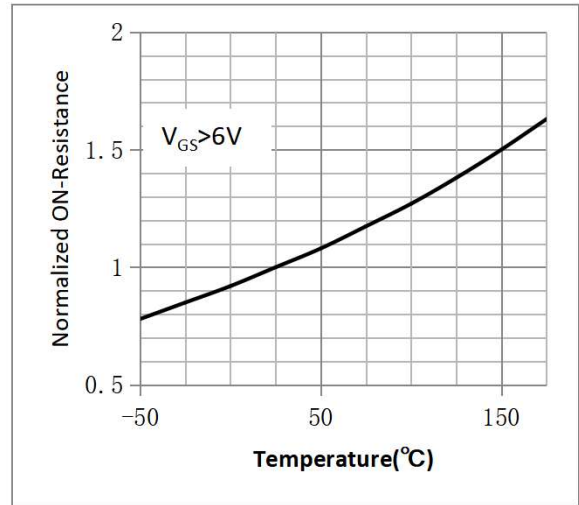


Figure 9. Diode Forward Voltage vs. Current

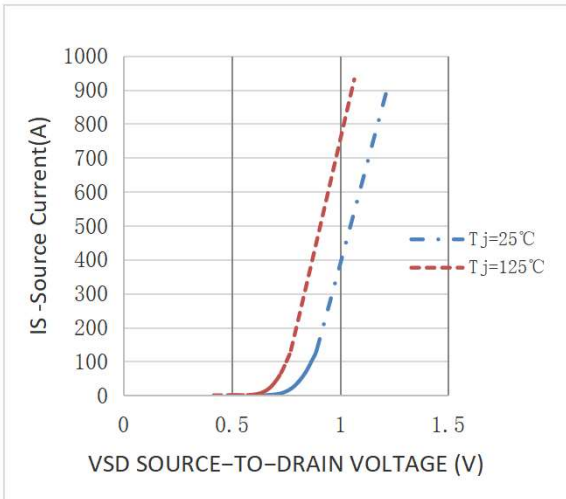


Figure 10. Transfer Characteristics

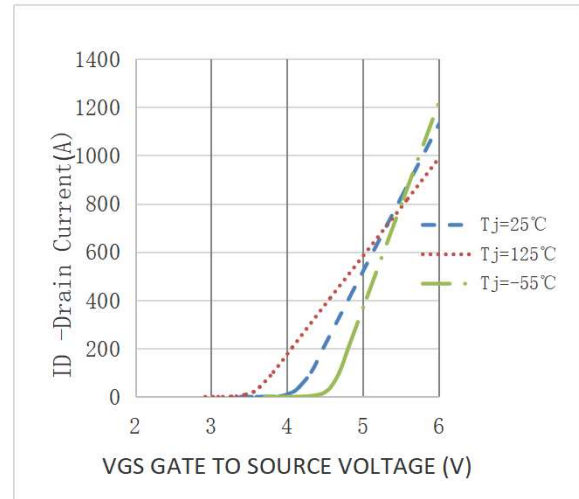


Fig.11 Safe Operating Area

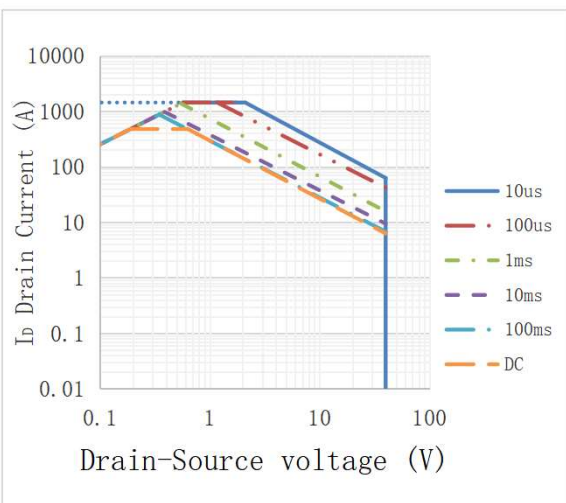
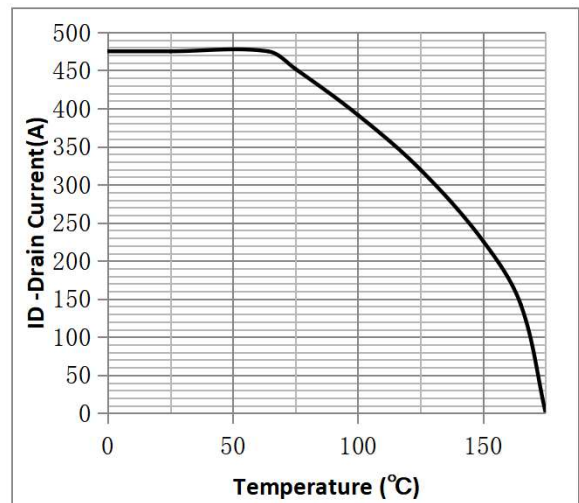
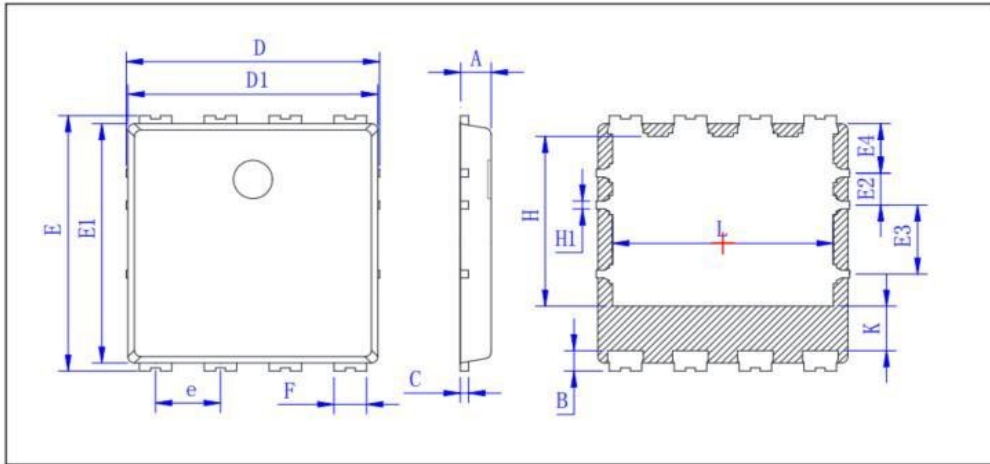


Fig.12 ID vs. Case Temperature<sup>③</sup>





•DFN8\*8 Package Outline



Symbol	Min	Typ	Max
A	0.90	0.95	1.00
B	0.50	0.60	0.70
C	0.254 TYP		
D	7.70	7.80	7.90
D1	7.60	7.70	7.80
E	7.90	8.00	8.10
E1	7.40	7.50	7.60
E2	0.90	1.00	1.10
E3	2.06	2.16	2.26
E4	1.45	1.55	1.65
e	2.0 TYP		
F	1.00 TYP		
H	5.15	5.30	5.40
H1	0.20	0.25	0.35
L	6.60	6.80	6.90
K	1.20		

**Note:**

- ① Pulse :  $V_{GS}=+20V/-20V$ , Duty cycle=50%,  $T_j=175^{\circ}C$ ,  $t=1000$  hours; For DC , the following test conditions can be passed:  $V_{GS}=+20V/-10V$ ,  $T_j=175^{\circ}C$ ,  $t=1000$  hours;
- ② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ③ Practically the current will be limited by PCB, thermal design and operating temperature.  $V_{GS}=10V$ .

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Revision History

Version	Date	Change
A	2022.11.6	New
B	2022.12.8	1.ID and ID curve Modified
C	2023.12.18	Corect SOA Curve
D	2024.11.6	RDSon modified.